			APPLICA		FOR	EXTENSI	ON OF ES		JALIFI	CATION APPROVAL		Page 1	
	SCC	Com	ponent Title:	С	MOS	3 B, 4000)B Series	i				Appl. No	Э.
		Exec	xecutive Member: CNES Date: 24/01/2022					pate: 24/01/2022		73T			
Components (includir	ng series and familie	es) subr	nitted for Exte	ension	of Qu	alification	Approval:						1
ESCC COMPONENT NO.	VARIANTS		RANGE OF COMPONENTS BASED ON TEST VEHICLE / S							COMPONEN ⁻ SIMILAR	т		
As per QPL										HCC4053KG	As p	per QPL	
									HCC40106KG				
Component Ma	anufacturer	2			nufact	turing Plar	ıt(s)	3					4
STMicroelectronics		R	Rennes, FRAN	1CE					Date Date:	of original qualification a : 01/04/1981	oprova	1:	
									Certi	ficate Ref No. 73			
	r]		licale Ref No. 70			
ESCC Specifications	used for	5 D	 Deviations to LVT testing and Detail Specification					Qualification Extension Report					
Maintenance of qualit Generic: 9000		us	used:					reference and date: HCC4053KG ID 33737004Z4 DC2038A					
			15)				UX.		240106KG ID 33737002				
Detail(s): ESCC 9202/049 I	lssue: Issue 5		Deviation from current Specifications: No ✓ Yes □ (Supply details)										
ESCC 9409/043 I													
Summary of procures	mont or equivalent to	oet resul	ute during cur	ront va	lidity	period in s	support of t	hie an	nlicatic	on (those to ESCC listed f	iret)		8
Customer Name			sults during current validity period in support of this ap				piloado	Quantity		əred			
SeeExcelFile	ESCC9000 Is 10	sue		Lots delivered from Janua 2020 to December 2021									
PID changes since st	art of qualification			9	Cur		Verified by			CNES			10
None			L		Current PID Verified by: CNES Name of Excutive Representa					entative	e Agency	10	
Minor*					Ref	f No:			RIQUE Ref. 8097046 revision 33.0, 09/11/2021, 4000B Ref. 8237618 rev.12.0, 30/08/2021				
Major* 🛛	*Provide details in b	box:			Issu	le:	33.0 (Gen					24/01/2022	
					Rev	v Date:							11
Current Manufacturing facilities surveyed by:						CNES			or	ı 24	/01/20	122	11
				(Name	of E	xecutive R	Representat	tive Aç	gency)		(Date)	1	
Satisfactory:	Yes 🛛		No 🗆	Exp	olain	See M	1oM of the	Qualit	y Meet	ting held on the 24th of Ja	anuary	2022	
	DTN-QE-EC-2	2022.00(01300,										
Report Reference:	31/01/2022			-									

APPLICATION FOR EXTENSION OF ESCC QUALIFICATION APPROVAL								
ESCC	Component title:	CMOS B, 40	000B Series			Appl. N	lo.	
	Executive Member:	CNES		Date:	24/01/2022	73T		
				000T	1004	L	12	
Failure Analysis, DPA, NCCS ava	ailable: Yes	🛛 No	☐ (Supply data)	2CSTN	//001			
inside. No e	explanation found for the	he origin of the		produced	inor. Product atypic with m d in AMK 6" without proble le 24 th of January 2022).			
The undersigned hereby certifies on behalf that the appropriate documentation has bee (except as stated in box 15;) - that the repo CNES as the responsible Executive Mem	en evaluated; - that ful rts and data are availa	l compliance to able at the ESC	all ESCC requirements i C Executive and therefor	s evideno e applies	s on behalf of	mere	13	
Date: 01/02/2022					JP. BUSSENO	Г		
				(Si	gnature of the Executive C	Coordinator)		
Continuation of Boxes above:							14	
[7] Qualification Extension reports	s :							
The extension is based on collecti	on of 54HCMOS a	nd CMOS 40	00B data :					
AMK 4" and 5":								
HCC4093BKG ID 33920001ZZ DC19	24B – ESCC9000 (Chart F4 sg1	-2					
HCC40106KG ID 33549002ZC DC20	40A – ESCC9000 (Chart F4 sg2						
AMK 6":								
HCC4053KG ID 33737004Z4 DC203	8A – ESCC9000 CI	nart F4 sq2						
HCC4043BKG ID 3394900401 DC19		-						
Package qualification: Dual in Line: M54HC393DGE – ID3 Flat pack: M54HC109KG - ID33835 Cover the validation of packages f refers).	002ZC DC2039A -	ESCC 9000	chart F4 sg1-3	at its ma	arch 2001 meeting (m	inute 11.1		
[9] Minor PID changes:								
- Some products are now available	e in AMK 6"							
- Some product were deleted (term	· ,							
- Delete of Catania 4" wafer fab an		w alastriaal f	contor ASI 1K					
- Replacement of the J325 electric	al tester by the he	welectrical	ester ASLTK					

		API	PLICATION FOR EXTENSION OF ESCC QU	ALIFICATION APPROVAL	Page 3
	ESCC	Component	t title: CMOS B, 4000B Series		Appl. No.
		Executive N	lember: CNES	Date: 24/01/2022	73T
Non comr	bliance to ESCC requirements:				15
No.:	Specification		Paragraph	Non complianc	0
NO	Specification		Falaylapii	Non complianc	e
Additional noncompl	tasks required to achieve full co iance:	mpliance for E	ESCC qualification or rationale for acceptability	/ of	16
Executive	Manager Disposition				
					17
Applicatio Action / R		No 🗆			
				0 -	
				Digitall	y signed a Schade
				Britta Schade by Britt	
Date:					2 +01'00'
				B. Schade: Head of the Produce and Safety Departmen	

	APPLICATIO	ON FOR EXTENSION OF ESC	FOR EXTENSION OF ESCC QUALIFICATION APPROVAL					
ESCC	Component Title:	CMOS B, 4000B Series			Appl. No	э.		
	Executive Member:	CNES	Date:	24/01/2022	73T			
ANNEX 1: LIST OF TESTS DONE TO SUPPORT EXTENSION OF QUALIFICATION								
Tests conducted in compliance with:								
 ESCC 9000 generic specificati Or PID-TFD Tests vehicle identification/description:	on; Chart F4 (for ESC (for ESCC/QML p							
AMK 4" and 5": HCC4093BKG ID 33920001ZZ DC HCC40106KG ID 33549002ZC DC	AMK 6": HCC4053KG ID 337 HCC4043BKG ID 33							
Dual in Line : M54HC393DGE – ID Flat-pack : M54HC109KG - ID33		54HCMOS families	as agreed by Qualif	ication Board at				

Detail Specification reference: 9202/049, 9409/043 ...

Chart F4	Test	Tick when done	Conditions	Date Code Diffusion Lot	Tested Qty	No. of Rejects	Comments if not performed. Comments on Rejection
⊑nvironmental/Mechanical Subgroup	Mechanical Shock	\boxtimes	MIL-STD-883, Test Method 2002		15	0	
	Vibration	\boxtimes	MIL-STD-883, Test Method 2007	Dual in Line : M54HC393DGE – ID33803008ZN DC2043A	15	0	
	Constant Acceleration	\boxtimes	MIL-STD-883, Test Method 2001		15	0	
	Seal (Fine and Gross Leak)	\boxtimes	MIL-STD-883, Test Method 1014		15	0	
	Intermediate and End-Point Electrical Measurements		Intermediate and End-Point Electrical Measurements in the Detail Specification		ID33803008ZN DC2043A	15	0
	External Visual Inspection	\boxtimes	ESCC Basic Specification No. 20500	Flat-pack : M54HC109KG - ID33835002ZC DC2039A	15	0	
elltal/l	Thermal Shock	\boxtimes	MIL-STD-883. Test Method 1011		15	0	
	Moisture Resistance	\boxtimes	MIL-STD-883, Test Method 1004		15	0	
	Seal (Fine and Gross Leak)	\boxtimes	MIL-STD-883, Test Method 1014		15	0	
	Intermediate and End-Point Electrical Measurements	X	Intermediate and End-Point Electrical Measurements in the Detail Specification		15	0	
	External Visual Inspection		ESCC Basic Specification No. 20500		15	0	

	FCC			ON FOR EXTENSION OF ES	CC QUALII	FICATION A	PPROVAL	Page 5
()	ESC	G	Component title:	CMOS B, 4000B Series				Appl. No.
			Executive Member:	CNES		Date: 24/0	01/2022	73T
Chart F4	Test	Tick when done	Conditions	Date Code Diffusion Lot	Tested Qty	No. of Rejects	Comments if no Comments or	ot performed. n Rejection
Endurance Subgroup	Operating Life		MIL-STD-883, Test Method 1005	AMK 4" and 5":	15	0		
	Intermediate and End-Point Electrical Measurements	\boxtimes	Intermediate and End-Point Electrical Measurements in the Detail Specification	HCC4093BKG ID33920001ZZ DC1924B HCC40106KG	15	0		
	Seal (Fine and Gross Leak)		MIL-STD-883, Test Method 1014	ID33549002ZC DC2040A AMK 6":	15	0		
	External Visual Inspection	×	ESCC Basic Specification No. 20500	HCC4053KG ID33737004Z4 DC2038A HCC4043BKG ID3394900401 DC1951A	15	0		
Assembly Capability Subgroup	Permanence of Marking		ESCC Basic Specification No. 24800	Dual in Line : M54HC393DGE – ID33803008ZN			Not applicable	
	Terminal Strength	X	MIL-STD-883, Test Method 2004	DC2043A	5	0		
apability	Internal Visual Inspection		ESCC Basic Specification No. 20400	Flat-pack : M54HC109KG - ID33835002ZC DC2039A	5	0		
ibly C	Bond Strength		MIL-STD-883 Test Method 2011		2	0		
Assen	Die Shear or Substrate Attach Strength	\boxtimes	MIL-STD-883 Test Method 2019 or 2027		2	0		
Jal (
Additional Tests								
Ă								

r						1	
	000	APPLICATIO	ON FOR EXTENSION OF	ESCC QUALIFICATI	ON APPROVAL	Page 7	
	SCC	Component title:	CMOS B, 4000B Series			Appl. No.	
		Executive Member:	CNES	Date:	24/01/2022	73T	
NO	TES ON THE COMPL	ETION OF THE APPL	ICATION FORM FOR ES	CC QUALIFICATION	EXTENSION APPROVA	L	
ENTRIES Form heading			as given in its detail specif er and its sequential suffix		f the series, family; - the Ex	cecutive Member;	
Box 1	shall provide details given in the table; in particular there shall be listed: - the variants or range of variants; - the range of components (the ESCC code is recommended to indicate the values or values range, the tolerance, the voltage, etc); the designation given in the detail specification as 'base on'; - under Test Vehicle enter either an ESCC code or the specific characteristic capable of identifying the component tested (e.g., voltage of coil for a relay); - under component similar enter a cross if relevant.						
Box 2; 3 and 4	As per QPL entry;	otherwise, an explana	tion of the changes must b	be supplied.			
Box 5			il specifications, including tions are different from the				
Box 6	deviations this mus	st be listed in Box 15. I	ic and Detail Specification n case the referenced spe tes or not from such curren	cification in Box 5 hav			
Box 7	Must reference the	e report(s) supplied in s	support of the application.				
Box 8			t to the full ESCC System, of the relevant Generic Sp		,		
Box 9			ification or after the last Ex r the changes. Major chan			ch evolution shall	
Box 10			ate and actual date of ver uired date of extension.	ification. The date o	f verification of the currer	nt PID should be	
Box 11	practices, procedu	res, material, etc. used	physical visit to the plant d in manufacturing the com of ESCC Basic Specificati	ponents are as descr	ibed in the PID. This surve	y shall be carried	
Box 12		s) (NCCS) occurred du	ny Destructive Physical A uring the qualification valid				
Box 13	Enter only the nar Coordinator.	me of the Executive N	/lember (i.e., CNES, DLR	, ESTEC, etc.) and t	he signature of the respo	onsible Executive	
Box 14			and any of the boxes from into 14a, 14b, etc. if severa			nce the Box 14 in	
Box 15	Fill in Table as req	uested.					
Box 16		,	v by the Executive Membe herein or the reason(s) to	0		ly to be accepted	
Box 17			on the application itself, s all be entered clearly in Bo				
Box 18	Fill in Table as req	uested.					
Box 19	Confidential Detail	s of PID changes inclu	Iding those of a confidentia	al nature, shall be pro	vided.		
Box 20		nce with reference to s Ily numbered. If releva	specification(s) and parag nt state 'None'.	raph(s). To simplify r	eference in Box 16 each	nonconformance	
Box 21			v by the Executive Membe herein or the reason(s) to			y to be accepted	
Box 22	Additional Comme	nts.					